

Final Product/Process Change Notification

Document #:FPCN24244X Issue Date:03 Mar 2022

| Title of Change: | Qualification of onsemi ISMF fab (Malaysia) and consolidation of Assembly and Test site operations of Small Signal diode devices in SOT-23 packages. | |
|---|---|--|
| Proposed First Ship date: | 10 Jun 2022 or earlier if approved by customer | |
| Contact Information: | Contact your local onsemi Sales Office or Hiroshi.Koizumi@onsemi.com | |
| PCN Samples Contact: | Contact your local onsemi Sales Office. Sample requests are to be submitted no later than 30 days from the date of first notification, Initial PCN or Final PCN, for this change. Samples delivery timing will be subject to request date, sample quantity and special customer packing/label requirements. | |
| Additional Reliability Data: | Contact your local onsemi Sales Office or Nicky.Siu@onsemi.com | |
| Type of Notification: | This is a Final Product/Process Change Notification (FPCN) sent to customers. FPCNs are issued 90 days prior to implementation of the change. onsemi will consider this change accepted, unless an inquiry is made in writing within 30 days of delivery of this notice. To do so, contact PCN.Support@onsemi.com | |
| Marking of Parts/ Traceability of Change: | Customer may receive the parts once FPCN expired or earlier depending on customer approval. Parts from new assembly & test site can be identified through product marking which follow onsemi marking format. | |
| Change Category: | Wafer Fab Change, Assembly Change, Test Change | |
| Change Sub-Category(s): | Manufacturing Site Transfer, Material Change | |
| Sites Affected: | | |
| | | |

| onsemi Sites | External Foundry/Subcon Sites |
|-------------------------------------|-------------------------------|
| Leshan Phoenix Semiconductor, China | AUK Corporation, Korea |
| onsemi Cebu, Philippines | JCET, China |
| onsemi Seremban, Malaysia | Phenitec Semiconductor, Japan |

Description and Purpose:

This is the final notification of onsemi's plan to consolidate assembly & test site to Leshan Phoenix Semiconductor, China and JCET, China and wafer fab site from Phenitec Semiconductor, Japan to onsemi Seremban, Malaysia on the impacted devices. This change, initiated from the Phenitec HD fab closure, ensures continuity of supply for our customers. All receiving sites are ISO/TS16949:2009 certified.

Qualification tests are designed to show that the reliability of the transferred devices will continue to meet or exceed onsemi standard.

| | Before Change Description | After Change Description |
|-----------------------|---|---|
| Assembly/Test Site | onsemi, Cebu, Philippines Leshan Phoenix Semiconductor, China AUK Corporation JCET,China | Leshan Phoenix Semiconductor, China JCET,China |
| Wafer FAB /BG/BM Site | Phenitic Semiconductor, Japan | onsemi Seremban, Malaysia |
| Top metal | Al | AlSi |
| Back metal | TiNiAgSn Au | |
| Lead Frame | Ag plated LF (Leshan) Ag Plated LF (JCET) | |
| Bond wire 0.8mil Au | | 0.8mil bare Cu (Leshan) 0.8mil Pd-coated Cu (JCET) |

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| Mold Compound | CK5000A EDALE ELER-8-100HFE Sumitomo G600FB | Hysol GR640 HV (Leshan) ELER-8-100HFE (JCET) |
|---------------|---|---|
|---------------|---|---|

There is no product marking change as a result of this change

Reliability Data Summary:

QV DEVICE NAME: MMBD1504A

RMS: 77130 PACKAGE: SOT-23

| Test | Specification | Condition | Interval | Results |
|-------|------------------------------------|--|------------|---------|
| HTRB | JESD22-A108 | Ta=150°C, 100% max rated V | 1008 hrs | 0/240 |
| HTSL | JESD22-A103 | Ta= 150°C | 1008 hrs | 0/240 |
| IOL | MIL-STD-750 (M1037) AEC-Q101 | Ta=+25°C, delta Tj=100°C On/off = 2 min | 15,000 cyc | 0/240 |
| TC | JESD22-A104 | Ta= -65°C to +150°C | 1000 cyc | 0/240 |
| H3TRB | JESD22-A101 | 85°C, 85% RH bias | 1008hrs | 0/240 |
| uHAST | JESD22-A118 | 130°C, 85% RH, 18.8psig, unbiased | 96 hrs | 0/240 |
| PC | J-STD-020, JESD22-A113 | MSL 1 @ 260 °C | | Pass |
| RSH | JESD22- B106 | Ta = 265°C, 10 sec | | 0/30 |
| SD | J-STD-002 | Ta = 245°C, 5 sec | | 0/45 |

QV DEVICE NAME: BAV23S

RMS: 63413 PACKAGE: SOT-23

| Test | Specification | Condition | Interval | Results |
|-------|------------------------------------|--|------------|---------|
| HTRB | JESD22-A108 | Ta=150°C, 100% max rated V | 1008 hrs | 0/240 |
| HTSL | JESD22-A103 | Ta= 150°C | 1008 hrs | 0/240 |
| IOL | MIL-STD-750 (M1037) AEC-Q101 | Ta=+25°C, delta Tj=100°C On/off = 2 min | 15,000 cyc | 0/240 |
| TC | JESD22-A104 | Ta= -65°C to +150°C | 1000 cyc | 0/240 |
| HAST | JESD22-A110 | 130°C, 85% RH, 18.8psig, bias | 96 hrs | 0/240 |
| uHAST | JESD22-A118 | 130°C, 85% RH, 18.8psig, unbiased | 96 hrs | 0/240 |
| PC | J-STD-020, JESD22-A113 | MSL 1 @ 260 °C | | Pass |
| RSH | JESD22- B106 | Ta = 265°C, 10 sec | | 0/30 |
| SD | J-STD-002 | Ta = 245°C, 5 sec | | 0/45 |

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Electrical Characteristics Summary:

The temperature characterization meets datasheet specification. Detail of Electrical characterization result is available upon request.

List of Affected Parts:

Note: Only the standard (off the shelf) part numbers are listed in the parts list. Any custom parts affected by this PCN are shown in the customer specific PCN addendum in the PCN email notification, or on the <u>PCN Customized Portal</u>.

| Part Number | Qualification Vehicle |
|----------------|-----------------------|
| MMBD1501A | MMBD1504A, BAV23S |
| MMBD1503A | MMBD1504A, BAV23S |
| MMBD1503A-D87Z | MMBD1504A, BAV23S |
| MMBD1504A | MMBD1504A, BAV23S |
| BAS35 | MMBD1504A, BAV23S |
| BAS31-D87Z | MMBD1504A, BAV23S |
| BAS31 | MMBD1504A, BAV23S |
| BAS29 | MMBD1504A, BAV23S |
| MMBD1405 | MMBD1504A, BAV23S |
| MMBD1404 | MMBD1504A, BAV23S |
| MMBD1403 | MMBD1504A, BAV23S |
| MMBD1401 | MMBD1504A, BAV23S |
| MMBD1505A | MMBD1504A, BAV23S |

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